Model 479 Twin Channel Optically Isolated Pyroelectric IR Detector with Source Follower



Manufactured under one or more of the following U.S. patents: 3,839,640 - 4,218,620 - 4,326,663 - 4,384,207 - 4,437,003 - 4,441,023 - 4,523,095

Model 479 contains two lithium tantalate sensing elements and two JFET source followers sealed into a standard TO-5 transistor package with two optical filters.

A patented element mounting technique is used to improve the thermal time constant and reduce effects of microphony.

A source resistor is needed to set the drain current and consequently the operating parameters of the JFET. A $47k\Omega$ or greater value is recommended.

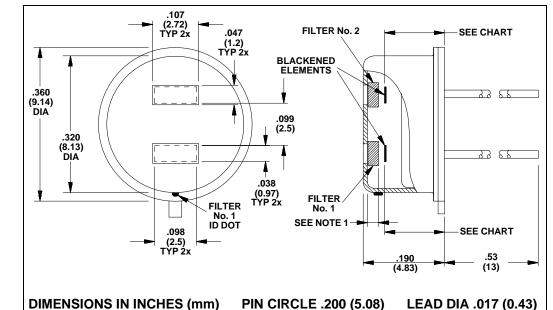
Model 479M1 Twin Channel Optically Isolated Pyroelectric IR Detector with High Gain Electronics

Manufactured under one or more of the following U.S. patents: 3,839,640 - 4,218,620 - 4,326,663 - 4,384,207 - 4,437,003 - 4,441,023 - 4,523,095

Model 479M1 is similar to the **Model 479** except that the 479M1 has high gain electronics, a different value load resistor and different specifications. A 100k Ω or greater source resistor is recommended for this Model.

Applications

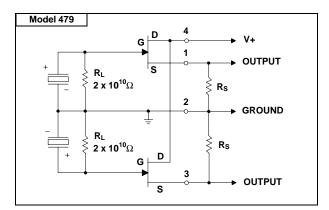
- Gas Analysis and Monitoring
- ATR (Attenuated Total Reflectance) for Liquids
- Medical Monitoring
- Flame Monitoring
- Increased Instrumentational Discrimination to Resolve Either/Or Situations
- 2-Color Pyrometers

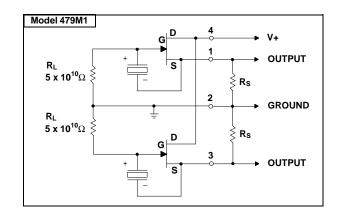


NOTES: 1. FILTER THICKNESS DEPENDENT ON TYPE. BOTH

- MODELS ACCOMMODATE FILTERS .010 TO .040 THICK. ELEMENT HEIGHT VARIES DEPENDING ON FILTER USED. SEE CHART.
 - 2. IF THE 2 INTERNAL FILTERS ARE THE SAME TYPE, THE ID DOT IS ELIMINATED.
 - 3. OBSERVE PRECAUTIONS FOR HANDLING ELECTROSTATIC SENSITIVE DEVICES.

ELEMENT / FILTER CHART				
FILTER	ELEMENT			
THICKNESS	HEIGHT			
.010	.155 (NOM)			
.020	.145 (NOM)			
.030	.135 (NOM)			
.040	.125 (NOM)			





3 4	PIN DESIGNATIONS					
	PIN # 1. FILTER No. 1 OUTPUT PIN # 2. GND / CASE					
2 1	PIN # 2. GND / CASE PIN # 3. FILTER No. 2 OUTPUT PIN # 4. V+					
BOTTOM VIEW	F IIN # 4. VŦ					

Characteristics	479	Unit	Test Conditions	479M1	Unit	Test Conditions	ELTECdata Reference
Detector Type	Twin Channel			Twin Channel			
Element Size	1.0 x 2.5	mm, each		1.0 x 2.5	mm, each		
	0.1 to 1,000	μm	Various Filters	0.1 to 1,000	μm	Various Filters	
Optical Bandwidth	3.71 to 3.89	μm	-380 Filter, CWL = 3.80 μm	3.71 to 3.89	μm	-380 Filter, CWL = 3.80 μm	101
	3.2575 to 3.4025	μm	-336 Filter, CWL = 3.33 μm	4.183 to 4.353	μm	-113 Filter, CWL = 4.268 μm	
Responsivity (typ)	2,080	V/W	3.80 µm Channel	12,990	V/W	3.80 µm Channel	
(typ)	1,970	V/W	3.33 µm Channel	10,110	V/W	4.268 µm Channel	
Channel Separation (typ)	30	dB		30	dB		
Noise (typ)	3.11	μVrms/√Hz	Each Channel	20.87	μVrms/√Hz	Each Channel	
NEP (typ)	1.53 x 10 ⁻⁹	W/√Hz	Each Channel	1.81 x 10 ⁻⁹	W/√Hz	Each Channel	100
D* (typ)	1.01 x 10 ⁸	cm√Hz/W	Each Channel	0.86 x 10 ⁸	cm√Hz/W	Each Channel	100
Operating Voltage (min) (max)	3 15	VDC	V+ to Gnd	5 10	VDC	V+ to Gnd	104 (4.1.c)
Offset Voltage (min) (max)	0.3 1.2	V	Each Channel R _S = 100 kΩ	0.8 3.0	V	Each Channel $R_S = 100 \text{ k}\Omega$	106 Section B
Operating Current (min) (max)	3.0 12	μA	Each Channel $R_S = 100 \text{ k}\Omega$	8.0 30	μΑ	Each Channel $R_S = 100 \text{ k}\Omega$	104 (4.1.c)
Thermal Breakpt. f _T (typ)	0.25	Hz		0.25	Hz		102
Electrical Breakpt. fe (typ)	0.19	Hz	$R_L = 2.0 \times 10^{10} \Omega$	0.15	Hz	$R_{L} = 5.0 \times 10^{10} \Omega$	102
Recommended Operating Temperature	-40 to +70	°C	Functional	-40 to +70	°C	Functional	
Storage Temperature	-55 to +125	°C	Δ T<50C°/min	-55 to +125	°C	∆ T<50Cº/min	
Output Impedance	< R _S	Ω		< R _S	Ω		
Output Protection	Do not exceed a	maximum dra	ain current of 50 μA	Do not exceed a	maximum dra	in current of 2 mA	

Characteristics at: Model 479-380/336:

For Both Models:

Model 479M1-380/113: 3.80 μ m Channel: 3.71 μ m to 3.89 μ m, 500°K, 2 Hz, 1 Hz BW, R_T = 25°C, R_S = 100 k\Omega 4.268 μ m Channel: 4.183 μ m to 4.353 μ m, 500°K, 2 Hz, 1 Hz BW, R_T = 25°C, R_S = 100 k Ω Data is established on a sample basis and is believed to be representative.

3.80 μm Channel: 3.71 $\mu m\,$ to 3.89 $\mu m,$ 500°K, 2 Hz, 1 Hz BW, R_{T} = 25°C, R $_{S}$ = 100 k Ω 3.33 μm Channel: 3.2575 $\mu m\,$ to 3.4025 $\mu m,\,$ 500°K, 2 Hz, 1 Hz BW, R_T = 25°C, R_S = 100 k\Omega For best results, the following precautions and recommendations should be observed. (See ELTECdata #101):

Mounting: Avoid mechanical stresses on case and leads.

Soldering: Detectors must be hand soldered to minimize the chance of destroying the internal components. Avoid machine or hot air soldering. Leave a minimum lead length of .250 inch (6.35mm). When soldering to detector leads, use a heat sink between the case and leads. Beware that the new RoHS compliant solders require a higher soldering temperature making heat sinking the detector extremely important.

Static Discharge: Protect detectors from electro-static charges.

Thermal Shock: Temperature changes and rate of change must be kept to a minimum (<50C⁰/min.) to prevent damage.

Noise: As a resolution or lower information limit, noise is established not only by the detector. Other noise sources are:

- · Radiated and conducted RF signals
- Subsequent amplification or signal conditioning stages
- · Power supply noise
- Components, such as high value resistors and capacitors (tantalum and aluminum electrolytic)
- · Mechanical contacts and weak solder joints
- · Shock and vibration excited microphonics
- Outside thermal influences on the detector other than the desired infrared input, i.e. drafts

All of these noise sources should be considered carefully when the information signal is <1mV.

Light Leakage: Slight sensitivity to visible light leaking through the glass-to-metal seal on the base may be observed.

Optical Design: Use of a detector with a filter in an optical system may require consideration of the image displacement toward the filter. This displacement (s) caused by the insertion of a planoparallel plate (filter thickness = t; refractive index = N) is given by s = (t/N)(N-1).

> **NOTICE:** The information provided herein is believed to be reliable. However, ELTEC Instruments, Inc. assumes no responsibility for inaccuracies or omissions. Due to industry components being incorporated into ELTEC's devices and ELTEC continually striving for product improvement, specifications may change without notice.



©ELTEC INSTRUMENTS, INC. 04/2016 Printed in U.S.A. Form DS479 (E-04/2016)